Search Notes

Application/Control No.	Applicant(s)/Patent Reexamination	Applicant(s)/Patent under Reexamination	
10/734,106	USUI, TAKAMASA		
Examiner	Art Unit	•	

2811

Steven Loke

			<del></del> -	
SEARCHED				
Class	Subclass	Date	Examiner	
257	211,	7/10/05	Loke	
	773,	•	:	
	775,			
	776,			
	774			
174	26/			
	·			
	·			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		·		
	1			

(INCLUDING SEARCH STRATEGY)			
,	DATE	EXMR	
		,	
	·		
	•	:	
		<del> </del>	